Truncated Nonlinear Interferometry for Quantum-Enhanced Atomic Force Microscopy

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Nonlinear interferometers that replace beam splitters in Mach-Zehnder interferometers with nonlinear amplifiers for quantum-enhanced phase measurements have drawn increasing interest in recent years, but practical quantum sensors based on nonlinear interferometry remain an outstanding challenge. Here, we demonstrate the first practical application of nonlinear interferometry by measuring the displacement of an atomic force microscope microcantilever with quantum noise reduction of up to 3 dB below the standard quantum limit, corresponding to a quantum-enhanced measurement of beam displacement of 1.7 fm/ $\sqrt{\text{Hz}}$. Further, we minimize photon backaction noise while taking advantage of quantum noise reduction by transducing the cantilever displacement signal with a weak squeezed state while using dual homodyne detection with a higher power local oscillator. This approach may enable quantum-enhanced broadband, high-speed scanning probe microscopy.

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Over the past four decades, squeezed states of light have been developed for quantum-enhanced interferometry capable of resolving signals beyond the photon shot-noise limit (SNL) [1–4]. More recently, nonlinear interferometers (NLIs), SU(1,1) interferometers in which beam splitters are replaced with nonlinear amplifiers, have arisen as a new type of interferometry that relies on the squeezing Hamiltonian [5–10]. In parallel with the development of quantum-enhanced interferometry, classical beam displacement measurements relying on segmented photodetection found widespread application in sensing and microscopy [11–14]. Just as squeezed light was shown to help surpass the SNL in interferometers [1], it has been shown that beam displacement measurements can surpass the SNL using squeezed states of light [15–17].

Atomic force microscopy (AFM) relying on segmentedphotodiode beam displacement measurements or Michelson interferometric readout is now well understood to be limited by a variety of noise sources, including photon shot noise, laser backaction noise, laser pointing stability, mechanical vibration, electronic noise of the detector, and thermal noise resulting from the resonant cantilever interactions with the surrounding heat bath [11,12,14,18–20]. Many of these noise sources can be minimized through proper system design, but the standard quantum limit (SQL), defined as the quadrature sum of backaction noise and shot noise, can only be surpassed with quantum states of light [1,2,21]. Thermal noise typically exceeds the SQL at the cantilever's resonance frequency [14,18]. When off resonance, AFMs operate at the SNL, and the readout power cannot be further increased because of thermal effects and backaction noise [17].

AFMs are generally operated at the cantilever resonance frequency because resonant operation provides 1-2 orders of magnitude improvement in signal-to-noise ratio (SNR) [22]. However, AFM performed on resonance effectively imposes a narrow band amplifier on the microscope, substantially narrowing the available material bandwidth that can be probed and slowing measurements due to micromechanical ringdown effects. For a wide variety of high-speed microscopies, including mass sensing or protein pulling and unfolding experiments, it is preferred to operate off resonance despite the reduction in sensitivity [23–25]. Sufficient reduction in the noise floor provided by a squeezed readout field would enable nonresonant AFM capable of probing broadband rf nanoscale material properties. This Letter aims to address the fundamental physics needed to enable these new approaches to atomic force microscopy.

While quantum sensors relying on squeezed light sources are increasingly capable of surpassing the sensitivity of optimized classical sensors [17,26-33], the quantum noise reduction in these sensors is highly dependent on optical loss, and the difficulty involved in controlling the spatial distribution of quantum correlations has limited the practicality of squeezed beam displacement measurements with segmented photodetectors [16,17]. NLIs offer the potential to outperform classical interferometers by a factor proportional to their nonlinear gain [5-7], and their benefit can be traced to the amount of squeezing generated by the nonlinear amplifier. Truncated NLIs replace the second nonlinear amplifier of a NLI with balanced homodyne detection while maintaining the phase sensitivity of the SU(1,1) interferometer [34-36]. While a traditional interferometer signal is proportional to the classical sensing power, a truncated NLI maintains the same signal scaling while reducing the noise floor by a factor proportional to the gain, thereby achieving the same sensitivity as a full NLI. Here, we describe a truncated NLI measurement of the displacement of an AFM microcantilever, and we show that this quantum microscope fully eliminates the previous requirement for spatial control over quantum correlations [16,17], drastically improving its practicality while allowing for classically inaccessible interferometric measurements.

The truncated NLI demonstrated here relies on the same four-wave-mixing process that has previously been used for squeezed AFM cantilever beam displacement measurements on segmented photodetectors [17]. As shown in Fig. 1, and as described in the Supplemental Material [37], a strong pump beam and a weak probe seed beam redshifted 3.042 GHz from the pump are mixed at an angle of 0.3° in a 12.7 mm long ⁸⁵Rb vapor cell held at roughly 116.5 °C to produce a conjugate beam via four wave mixing, resulting in measured intensity difference squeezing of up to 5 dB relative to the SNL when measured directly after the vapor cell. As previously reported, a tapered amplifier operating as a master oscillator power amplifier provided a stable, compact, and low-cost laser source [38]. Here, the truncated NLI replaces intensity difference measurements with dual homodyne interferometry. For all of the datasets reported here, the power of the squeezed probe and conjugate fields were roughly 1.5 and 1.4 μ W, respectively, and the power of the probe and conjugate LOs were roughly 110 and 70 μ W, respectively. A proportional-integral controller was used to phase lock the measurement at the center of the interference fringes. The spectrum analyzer settings included a 10 kHz resolution bandwidth, 30 Hz video bandwidth, 0.5 s sweep time, and 20 averages.

AFM beam displacement measurements were performed with either the probe or the probe's LO reflected from a gold-coated AFM microcantilever with a fundamental resonance of 13 kHz and a force constant of 0.2 N/m in a Bruker piezoactuated AFM mount driven at 737 kHz. Notably, using either the probe or the probe's LO to transduce the microcantilever motion results in qualitatively similar responses despite fundamentally different operating regimes. When the probe is reflected from the cantilever, the 5% loss on the cantilever results in 0.2 dB reduction in squeezing. When the probe's LO is reflected from the cantilever, optical loss on the LO does not affect the measured squeezing, but mode mismatches still result in an increase in the noise sidebands toward the SNL as described by a beam splitter model [39]. The signal degrades via the same beam splitter model. Here, the mode matching between the probe and its LO was optimized by passing the probe through the same optical train with the cantilever replaced by a macroscopic mirror, as shown in Fig. 1. Critically, as seen in Eqs. (1) and (2) below, using



FIG. 1. An acousto-optic modulator (AOM) redshifts the probe 3.042 GHz from the pump. A polarizing beam splitter (PBS) combines two cross-polarized pump and probe beams in the Rb vapor cell to generate a weak two-mode squeezed state (probe shown in red, conjugate in orange) and corresponding high-power local oscillators (LOs). Varying the relative power of the two seed probe beams enables the probe and conjugate to be easily converted into LOs and vice versa. Either the probe or the probe's LO is reflected from the AFM microcantilever (MC). To optimize mode matching before the twin-beam LOs are mixed with the twin-beam squeezed states on 50/50 beam splitters (BSs), they pass through identical optics (PBS, lens) as shown in the inset, but one is reflected from the MC and the other from a 1 in. diameter mirror. The polarization is rotated 90° to allow transmission through the PBS. A hybrid junction is used to take the sum and difference signals from the two homodyne detectors and display them on a pair of spectrum analyzers.

the probe rather than the probe LO to transduce the cantilever response virtually eliminates backaction noise from the readout, whereas a high-power LO could induce backaction noise in excess of the photon shot noise if it were used to transduce the cantilever response.

For interferometric beam displacement measurements where the signal is purely based on the phase acquired by small displacements of the AFM cantilever, the cantilever displacement noise arising from the shot-noise limit is

$$\langle \Delta(\hat{X}_{-})^2 \rangle_{\text{SNL}} = \frac{1}{4\pi^2} \frac{hc\lambda\Delta f}{2P_{\text{tot}}}$$
 (1)

for wavelength λ , total optical power incident on the detectors P_{tot} , and measurement bandwidth Δf [14].

The backaction noise induced onto an optical readout field by a micromechanical cantilever operating near resonance with quality factor Q and spring constant k is

$$\langle \Delta(\hat{X}_{-})^2 \rangle_{\text{back}} = \frac{4Q^2}{k^2} \frac{2Ph\Delta f}{c\lambda},$$
 (2)

where *P* is the optical power incident on the cantilever [14]. For measurements performed off resonance, as in the data presented here, the backaction noise is significantly reduced as $Q \rightarrow 1$. The SQL is then given by the quadrature sum of Eqs. (1) and (2). Backaction noise will still contribute to the SQL at sufficiently high powers, but the present work was conducted deep into the shot-noise-limited regime.

In the presence of squeezing, the smallest measurable beam displacement signal described in Eq. (1) is modified by a squeezing parameter r [15]

$$\langle \Delta(\hat{X}_{-})^2 \rangle_{\text{SNL}} = \frac{1}{4\pi^2 e^{2r}} \frac{hc\lambda\Delta f}{2P_{\text{tot}}}.$$
 (3)

For r = 0 (with a coherent laser readout, for instance), one recovers the standard minimum resolvable displacement proportional to the inverse square root of intensity. Equation (3) applies to both absolute displacement measurements and relative displacement measurements. The only requirement is that, for r > 0, the readout field shows relative intensity squeezing if a differencing measurement is used as the transduction mechanism. Thus, Eq. (3) can straightforwardly be extended to the twin-beam, multimode squeezing case used in Ref. [17] by changing the measurement to the difference in displacement between two beams of light, rather than using only a single beam of light to transduce the signal.

For relative quadrature difference measurements of twomode squeezed states, one can show that the cantilever displacement noise normalized against the shot-noise limit is given by

$$\frac{\Delta(X_{-})^{2}}{n_{\text{SNL}}} = \eta \{\sinh 2r \tanh 2r [2\cos\left(\theta_{p} + \theta_{c} - \phi\right)] + \cosh 2r - \tanh^{2}2r + \sinh 2r \tanh 2r - 1\} + \tanh^{2}2r + 1, \qquad (4)$$

where η is the composite detection efficiency, θ_p and θ_c are the homodyne phases for the probe and conjugate, and ϕ is the phase shift in the probe arm of the interferometer [34].

In the ideal case where $\eta = 1$ and $\theta_p = \theta_c = \pi/2$, and for minimum phase shifts of $\phi \approx 0$,

$$\frac{\langle \Delta(\hat{X}_{-})^2 \rangle}{n_{\rm SNL}} = \frac{1}{2G-1},\tag{5}$$

where $G = \cosh^2 r$ represents the gain in a nonlinear amplifier used to generate two-mode squeezing. This expression describes quantum noise reduction below the SNL for all G > 1. Further, it holds when the quadratures being measured are bright fields and when the phase quadrature corresponds to an optical phase, resulting in a quantum enhancement in the SNR compared with shotnoise-limited classical interferometry. In terms of the squeezing parameter r, one obtains the same scaling as in Eq. (3) for the minimum resolvable relative phase measurement between the two modes of the two-mode squeezed state.

It was also previously shown that noise in direct intensity measurements of differential beam displacement scales as $\langle \Delta(\hat{X}_{-})^2 \rangle \propto 1/(2G-1)$ [17]. This means that a differential beam displacement measurement using direct intensity detection has a SNR scaling equivalent to a relative phase measurement. However, if a nonlinear amplifier is used to produce squeezed quadratures, then such a relative phase measurement is equivalent to a phase measurement with a truncated NLI [35].

In addition, the truncated NLI has been shown in theory to have the same phase sensitivity as the full nonlinear interferometer [34]. Given this equivalence between the phase sensitivity of NLIs and truncated NLIs and the equivalence between the sensitivity of NLIs and quantum-enhanced direct intensity detection, we expect a phasemeasurement-based truncated NLI to be capable of the same SNR and noise reduction shown in the intensityreadout truncated NLI shown in [17]. The crucial difference for the truncated NLI is that all spatial mode dependence is contained in the mode matching between the LO and the signal modes, and thus no control of the spatial distribution of quantum correlations is required if the LO spatial modes are identical to the signals.

Figure 2(a) illustrates the measured phase-sum signal from the dual homodyne measurement when the weak squeezed state is reflected from the AFM cantilever, and the piezoactuator is driven at 40–180 mV (teal to orange, respectively). All signals are normalized to the SNL



FIG. 2. (a) Spectrum analyzer traces of microcantilever displacement normalized to SNL (dashed gray line) when a weak probe is reflected from the microcantilever before dual homodyne detection. Each line corresponds to a different voltage applied to the piezoelectric transducer on the AFM cantilever. (b) SNR of microcantilever displacement using squeezed light (circles) and coherent light (triangles).

(meaning that the 0 dB line is set to the SNL). Figure 2(b) illustrates the measured signal-to-noise ratio for each signal in Fig. 2(a) along with the corresponding signal-to-noise ratios for shot-noise-limited measurements. The measured phase-sum squeezing varied from 2.6 to 2.8 dB below the SNL.

Figures 3(a) and 3(b) illustrate the measured phase-sum signal and SNR, respectively, when the LO is reflected from the AFM cantilever instead of the weak squeezed state. All other experimental parameters remained the same. Here, the measured squeezing varied from 2.8 to 3.0 dB below the SNL. Notably, the measured SNR is almost 2 dB smaller in Fig. 2 than in Fig. 3. This suggests that some intensity difference signal, arising from relative misalignment of the probe LO, is present in these results. However, because only 2 dB difference in SNR is seen, despite roughly 70× difference in optical power, we can conclude that the results seen here are mostly a relative phase measurement.

For the experimental parameters described above, the SNL was 3.3 fm/ $\sqrt{\text{Hz}}$, the backaction noise when the LO was incident on the cantilever was 243 zm/ $\sqrt{\text{Hz}}$, and the



FIG. 3. (a) Spectrum analyzer traces of microcantilever displacement normalized to SNL (dashed gray line) when the LO is reflected from the microcantilever before dual homodyne detection. Each line corresponds to a different voltage applied to the piezoelectric transducer on the AFM cantilever. (b) SNR of microcantilever displacement using squeezed light (circles) and coherent light (triangles).

backaction noise when the weak probe was incident on the cantilever was 29 zm/ $\sqrt{\text{Hz}}$. The experiments performed here were limited to a low-gain regime by the available pump power and by Doppler broadening in the Rb vapor cell, but the LO power can plausibly be increased by 2 orders of magnitude by increasing the seed probe power, pump power, and vapor cell temperature without detrimentally effecting the dual homodyne detection. In such a regime, the measurements would still be shot-noise limited if the LO were used to read out the cantilever displacement, but laser heating of the cantilever would modify the cantilever and material properties. Thus, in the high-LO power regime, the low-power squeezed state must be used to read out the cantilever beam displacement. The measured phase-sum squeezing of up to 3 dB was also limited by operation in the low-gain regime, but squeezing in excess of 10 dB is possible with this squeezed light source [40]. Further, unlike other recent demonstrations of quantum sensors, where substantial loss is intrinsic to the sensor [27–29,31], only 5% optical loss is introduced by the current sensor design. The loss can be substantially further reduced by improving the reflective coating on the AFM cantilever. Finally, since the optimal measurement in this system is a relative phase-sum measurement, one can transduce a signal onto both the probe and conjugate fields (or both LOs) and measure the phase sum while maintaining quantum noise reduction. Thus, by reflecting the probe and conjugate fields from the same cantilever, the total signal could be doubled while still taking advantage of the improved dynamic range of the previously described NLI design.

By utilizing both the probe and conjugate fields to transduce the cantilever displacement, while optimizing the LO power, available squeezing, and optical loss, it is therefore possible to obtain greater than 2 orders of magnitude further improvement in SNR compared with the measurements reported here using current technology. Such an enhancement in sensitivity is comparable to the enhancement provided by operating an AFM at the micromechanical resonance frequency [14]. As a result, an optimized truncated nonlinear interferometric AFM should enable quantum-enhanced atomic force microscopy where the enhancement in SNR enabled by high-power LOs and optimized quantum noise reduction would offset the advantage of resonant operation. As currently designed and depending on the detector gain and relative delay between the probe and conjugate fields, the four-wavemixing source offers a quantum advantage over a bandwidth spanning roughly 1 kHz-20 MHz [41]. Variants of this source can enable squeezing down to 10 Hz [42]. Scanning probe microscopy incorporating this quantumenhanced readout technique can therefore provide a broadband modality in which the full rf sideband of the measured photocurrent could be used to characterize high-speed dynamics in materials.

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